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Details

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Product Status	Obsolete
Core Processor	PIC
Core Size	16-Bit
Speed	60 MIPs
Connectivity	I ² C, IrDA, LINbus, SPI, UART/USART
Peripherals	Brown-out Detect/Reset, DMA, POR, PWM, WDT
Number of I/O	53
Program Memory Size	512KB (170K x 24)
Program Memory Type	FLASH
EEPROM Size	-
RAM Size	24K x 16
Voltage - Supply (Vcc/Vdd)	3V ~ 3.6V
Data Converters	A/D 16x10b/12b
Oscillator Type	Internal
Operating Temperature	-40°C ~ 125°C (TA)
Mounting Type	Surface Mount
Package / Case	64-VFQFN Exposed Pad
Supplier Device Package	64-VQFN (9x9)
Purchase URL	https://www.e-xfl.com/product-detail/microchip-technology/pic24ep512gp206t-e-mr

Email: info@E-XFL.COM

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TABLE 4-64: BIT-REVERSED ADDRESSING SEQUENCE (16-ENTRY)

Normal Address						Bit-Reversed Address				
A3	A3 A2 A1 A0 Decimal		Decimal	A3	A2	A1	A0	Decimal		
0	0	0	0	0	0	0	0	0	0	
0	0	0	1	1	1	0	0	0	8	
0	0	1	0	2	0	1	0	0	4	
0	0	1	1	3	1	1	0	0	12	
0	1	0	0	4	0	0	1	0	2	
0	1	0	1	5	1	0	1	0	10	
0	1	1	0	6	0	1	1	0	6	
0	1	1	1	7	1	1	1	0	14	
1	0	0	0	8	0	0	0	1	1	
1	0	0	1	9	1	0	0	1	9	
1	0	1	0	10	0	1	0	1	5	
1	0	1	1	11	1	1	0	1	13	
1	1	0	0	12	0	0	1	1	3	
1	1	0	1	13	1	0	1	1	11	
1	1	1	0	14	0	1	1	1	7	
1	1	1	1	15	1	1	1	1	15	

U-0	U-0	U-0	U-0	U-0	U-0	U-0	U-0
—	—	—	_	_	—	_	—
bit 15							bit 8
U-0	R/W-0	R/W-0	R/W-0	R/W-0	R/W-0	R/W-0	R/W-0
—				OCFAR<6:0>	>		
bit 7	-						bit 0
Legend:							

REGISTER 11-6: RPINR11: PERIPHERAL PIN SELECT INPUT REGISTER 11

Legend:			
R = Readable bit	W = Writable bit	U = Unimplemented bit, read	l as '0'
-n = Value at POR	'1' = Bit is set	'0' = Bit is cleared	x = Bit is unknown

bit 15-7 Unimplemented: Read as '0'

bit 6-0 OCFAR<6:0>: Assign Output Compare Fault A (OCFA) to the Corresponding RPn Pin bits (see Table 11-2 for input pin selection numbers) 1111001 = Input tied to RPI121

> . 0000001 = Input tied to CMP1 0000000 = Input tied to Vss

U-0	U-0	U-0	U-0	U-0	U-0	U-0	U-0			
—	—	—	_	—	—	—	—			
bit 15							bit 8			
U-0	R/W-0	R/W-0	R/W-0	R/W-0	R/W-0	R/W-0	R/W-0			
—	U1RXR<6:0>									
bit 7							bit 0			
-										

REGISTER 11-10: RPINR18: PERIPHERAL PIN SELECT INPUT REGISTER 18

Legend:			
R = Readable bit	W = Writable bit	U = Unimplemented bit	, read as '0'
-n = Value at POR	'1' = Bit is set	'0' = Bit is cleared	x = Bit is unknown

bit 15-7 Unimplemented: Read as '0' bit 6-0 U1RXR<6:0>: Assign UART1 Receive (U1RX) to the Corresponding RPn Pin bits (see Table 11-2 for input pin selection numbers) 1111001 = Input tied to RPI121

REGISTER 11-11: RPINR19: PERIPHERAL PIN SELECT INPUT REGISTER 19

U-0	U-0	U-0	U-0	U-0	U-0	U-0	U-0
—	_		_	—	_	—	_
bit 15							bit 8
U-0	R/W-0	R/W-0	R/W-0	R/W-0	R/W-0	R/W-0	R/W-0
—				U2RXR<6:0>	>		
bit 7							bit 0
Legend:							

R = Readable bit	W = Writable bit	U = Unimplemented bit, read as '0'	
-n = Value at POR	'1' = Bit is set	'0' = Bit is cleared	x = Bit is unknown

bit 15-7 Unimplemented: Read as '0'

^{0000000 =} Input tied to Vss

REGISTER 11-26: RPOR8: PERIPHERAL PIN SELECT OUTPUT REGISTER 8

U-0	U-0	R/W-0	R/W-0	R/W-0	R/W-0	R/W-0	R/W-0			
—	—		RP118R<5:0>							
bit 15	bit 15 bit 8									
U-0	U-0	U-0	U-0	U-0	U-0	U-0	U-0			
_	—		_	_	_	—	—			
bit 7							bit 0			

Legend:				
R = Readable bit	W = Writable bit	U = Unimplemented bit, read as '0'		
-n = Value at POR	'1' = Bit is set	'0' = Bit is cleared	x = Bit is unknown	

bit 15-14	Unimplemented: Read as '0'
bit 13-8	RP118R<5:0>: Peripheral Output Function is Assigned to RP118 Output Pin bits (see Table 11-3 for peripheral function numbers)

bit 7-0 Unimplemented: Read as '0'

REGISTER 11-27: RPOR9: PERIPHERAL PIN SELECT OUTPUT REGISTER 9

U-0	U-0	U-0	U-0	U-0	U-0	U-0	U-0
—	—	—	—	—	—	—	—
bit 15							bit 8

U-0	U-0	R/W-0	R/W-0	R/W-0	R/W-0	R/W-0	R/W-0
—	—			RP120)R<5:0>		
bit 7							bit 0

Legend:			
R = Readable bit	W = Writable bit	U = Unimplemented bit, read	as '0'
-n = Value at POR	'1' = Bit is set	'0' = Bit is cleared	x = Bit is unknown

bit 15-6 Unimplemented: Read as '0'

bit 5-0 **RP120R<5:0>:** Peripheral Output Function is Assigned to RP120 Output Pin bits (see Table 11-3 for peripheral function numbers)

NOTES:

14.0 INPUT CAPTURE

- Note 1: This data sheet summarizes the features of the dsPIC33EPXXXGP50X, dsPIC33EPXXXMC20X/50X and PIC24EPXXXGP/MC20X families of devices. It is not intended to be a comprehensive reference source. To complement the information in this data sheet, refer to "Input Capture" (DS70352) in the "dsPIC33/dsPIC24 Family Reference Manual', which is available from the Microchip web site (www.microchip.com).
 - Some registers and associated bits described in this section may not be available on all devices. Refer to Section 4.0 "Memory Organization" in this data sheet for device-specific register and bit information.

The input capture module is useful in applications requiring frequency (period) and pulse measurement. The dsPIC33EPXXXGP50X, dsPIC33EPXXXMC20X/ 50X and PIC24EPXXXGP/MC20X devices support four input capture channels.

Key features of the input capture module include:

- Hardware-configurable for 32-bit operation in all modes by cascading two adjacent modules
- Synchronous and Trigger modes of output compare operation, with up to 19 user-selectable Trigger/Sync sources available
- A 4-level FIFO buffer for capturing and holding timer values for several events
- Configurable interrupt generation
- Up to six clock sources available for each module, driving a separate internal 16-bit counter





REGISTER 16-1: PTCON: PWMx TIME BASE CONTROL REGISTER (CONTINUED)

bit 6-4	SYNCSRC<2:0>: Synchronous Source Selection bits ⁽¹⁾ 111 = Reserved
	•
	• 100 = Reserved 011 = PTGO17 ⁽²⁾ 010 = PTGO16 ⁽²⁾ 001 = Reserved 000 = SYNCI1 input from PPS
bit 3-0	<pre>SEVTPS<3:0>: PWMx Special Event Trigger Output Postscaler Select bits⁽¹⁾ 1111 = 1:16 Postscaler generates Special Event Trigger on every sixteenth compare match event</pre>
	0001 = 1:2 Postscaler generates Special Event Trigger on every second compare match event 0000 = 1:1 Postscaler generates Special Event Trigger on every compare match event

- **Note 1:** These bits should be changed only when PTEN = 0. In addition, when using the SYNCI1 feature, the user application must program the period register with a value that is slightly larger than the expected period of the external synchronization input signal.
 - 2: See Section 24.0 "Peripheral Trigger Generator (PTG) Module" for information on this selection.

17.2 QEI Control Registers

|--|

R/W-0	U-0	R/W-0	R/W-0	R/W-0	R/W-0	R/W-0	R/W-0		
QEIEN		QEISIDL	PIMOD2 ⁽¹⁾	PIMOD1 ⁽¹⁾	PIMOD0 ⁽¹⁾	IMV1 ⁽²⁾	IMV0 ⁽²⁾		
bit 15							bit 8		
U-0	R/W-0	R/W-0	R/W-0	R/W-0	R/W-0	R/W-0	R/W-0		
_	INTDIV2 ⁽³⁾	INTDIV1 ⁽³⁾	INTDIV0 ⁽³⁾	CNTPOL	GATEN	CCM1	CCM0		
bit 7							bit 0		
Legend:									
R = Readable	bit	W = Writable	bit	U = Unimpler	nented bit, read	l as '0'			
-n = Value at I	POR	'1' = Bit is set		'0' = Bit is cle	ared	x = Bit is unkr	Iown		
bit 15	bit 15 QEIEN: Quadrature Encoder Interface Module Counter Enable bit 1 = Module counters are enabled 0 = Module counters are disabled, but SFRs can be read or written to								
bit 14	Unimplemented: Read as '0'								
bit 13	QEISIDL: QE	I Stop in Idle M	ode bit						
	 1 = Discontinues module operation when device enters Idle mode 0 = Continues module operation in Idle mode 								
bit 12-10	PIMOD<2:0>: Position Counter Initialization Mode Select bits ⁽¹⁾								
 111 = Reserved 110 = Modulo Count mode for position counter 101 = Resets the position counter when the position counter equals QEI1GEC register 100 = Second index event after home event initializes position counter with contents of QEI1IC register 011 = First index event after home event initializes position counter with contents of QEI1IC register 010 = Next index input event initializes the position counter with contents of QEI1IC register 010 = Every index input event resets the position counter 000 = Index input event does not affect position counter 									
bit 9	IMV1: Index Match Value for Phase B bit ⁽²⁾								
	1 = Phase B match occurs when QEB = 1 0 = Phase B match occurs when QEB = 0								
bit 8	IMV0: Index N	Match Value for	Phase A bit ⁽²⁾)					
	1 = Phase A r 0 = Phase A r	match occurs w match occurs w	/hen QEA = 1 /hen QEA = 0						
bit 7	bit 7 Unimplemented: Read as '0'								
	0014.4.0								

Note 1: When CCM<1:0> = 10 or 11, all of the QEI counters operate as timers and the PIMOD<2:0> bits are ignored.

2: When CCM<1:0> = 00, and QEA and QEB values match the Index Match Value (IMV), the POSCNTH and POSCNTL registers are reset. QEA/QEB signals used for the index match have swap and polarity values applied, as determined by the SWPAB and QEAPOL/QEBPOL bits.

3: The selected clock rate should be at least twice the expected maximum quadrature count rate.

REGISTER 18-1: SPIx STAT: SPIx STATUS AND CONTROL REGISTER (CONTINUED)

- bit 1 SPITBF: SPIx Transmit Buffer Full Status bit
 - 1 = Transmit not yet started, SPIxTXB is full
 - 0 = Transmit started, SPIxTXB is empty

Standard Buffer mode:

Automatically set in hardware when core writes to the SPIxBUF location, loading SPIxTXB. Automatically cleared in hardware when SPIx module transfers data from SPIxTXB to SPIxSR.

Enhanced Buffer mode:

Automatically set in hardware when the CPU writes to the SPIxBUF location, loading the last available buffer location. Automatically cleared in hardware when a buffer location is available for a CPU write operation.

bit 0 SPIRBF: SPIx Receive Buffer Full Status bit

1 = Receive is complete, SPIxRXB is full

0 = Receive is incomplete, SPIxRXB is empty

Standard Buffer mode:

Automatically set in hardware when SPIx transfers data from SPIxSR to SPIxRXB. Automatically cleared in hardware when the core reads the SPIxBUF location, reading SPIxRXB.

Enhanced Buffer mode:

Automatically set in hardware when SPIx transfers data from SPIxSR to the buffer, filling the last unread buffer location. Automatically cleared in hardware when a buffer location is available for a transfer from SPIxSR.

22.2 CTMU Control Registers

REGISTER	22-1. CTIVI			REGISTER	1		
R/W-0	U-0	R/W-0	R/W-0	R/W-0	R/W-0	R/W-0	R/W-0
CTMUEN	—	CTMUSIDL	TGEN	EDGEN	EDGSEQEN	IDISSEN ⁽¹⁾	CTTRIG
bit 15							bit 8
U-0	U-0	U-0	U-0	U-0	U-0	U-0	U-0
	—	—	_	—	—	_	
bit 7							bit 0
Legend:							
R = Readable bit W = Writable bit U = Unimplemented bit, read as '0'							
-n = Value at	POR	'1' = Bit is set		'0' = Bit is cle	ared	x = Bit is unkn	iown
bit 15	CTMUEN: C	TMU Enable bit					
	1 = Module i	s enabled					
	0 = Module i	s disabled					
bit 14	Unimplemented: Read as '0'						
bit 13	CTMUSIDL: CTMU Stop in Idle Mode bit						
	1 = Discontir	nues module ope	ration when	device enters lo	dle mode		
	0 = Continue	es module operat	ion in Idle mo	ode			
bit 12	TGEN: Time	Generation Enab	ole bit				
	1 = Enables	edge delay gene	eration				
	0 = Disables	edge delay gene	eration				
bit 11	EDGEN: Edd	e Enable bit					

REGISTER 22-1: CTMUCON1: CTMU CONTROL REGISTER 1

1 = Hardware modules are used to trigger edges (TMRx, CTEDx, etc.)

- 0 = Software is used to trigger edges (manual set of EDGxSTAT)
- bit 10 EDGSEQEN: Edge Sequence Enable bit
 - 1 = Edge 1 event must occur before Edge 2 event can occur
 - 0 = No edge sequence is needed
- bit 9 IDISSEN: Analog Current Source Control bit⁽¹⁾
 - 1 = Analog current source output is grounded
 - 0 = Analog current source output is not grounded
- bit 8 **CTTRIG:** ADC Trigger Control bit
 - 1 = CTMU triggers ADC start of conversion
 - 0 = CTMU does not trigger ADC start of conversion
- bit 7-0 Unimplemented: Read as '0'
- **Note 1:** The ADC module Sample-and-Hold capacitor is not automatically discharged between sample/conversion cycles. Software using the ADC as part of a capacitance measurement must discharge the ADC capacitor before conducting the measurement. The IDISSEN bit, when set to '1', performs this function. The ADC must be sampling while the IDISSEN bit is active to connect the discharge sink to the capacitor array.

23.2 ADC Helpful Tips

- 1. The SMPIx control bits in the AD1CON2 register:
 - a) Determine when the ADC interrupt flag is set and an interrupt is generated, if enabled.
 - b) When the CSCNA bit in the AD1CON2 registers is set to '1', this determines when the ADC analog scan channel list, defined in the AD1CSSL/AD1CSSH registers, starts over from the beginning.
 - c) When the DMA peripheral is not used (ADDMAEN = 0), this determines when the ADC Result Buffer Pointer to ADC1BUF0-ADC1BUFF gets reset back to the beginning at ADC1BUF0.
 - d) When the DMA peripheral is used (ADDMAEN = 1), this determines when the DMA Address Pointer is incremented after a sample/conversion operation. ADC1BUF0 is the only ADC buffer used in this mode. The ADC Result Buffer Pointer to ADC1BUF0-ADC1BUFF gets reset back to the beginning at ADC1BUF0. The DMA address is incremented after completion of every 32nd sample/conversion operation. Conversion results are stored in the ADC1BUF0 register for transfer to RAM using DMA.
- 2. When the DMA module is disabled (ADDMAEN = 0), the ADC has 16 result buffers. ADC conversion results are stored sequentially in ADC1BUF0-ADC1BUFF, regardless of which analog inputs are being used subject to the SMPIx bits and the condition described in 1c) above. There is no relationship between the ANx input being measured and which ADC buffer (ADC1BUF0-ADC1BUFF) that the conversion results will be placed in.
- 3. When the DMA module is enabled (ADDMAEN = 1), the ADC module has only 1 ADC result buffer (i.e., ADC1BUF0) per ADC peripheral and the ADC conversion result must be read, either by the CPU or DMA Controller, before the next ADC conversion is complete to avoid overwriting the previous value.
- 4. The DONE bit (AD1CON1<0>) is only cleared at the start of each conversion and is set at the completion of the conversion, but remains set indefinitely, even through the next sample phase until the next conversion begins. If application code is monitoring the DONE bit in any kind of software loop, the user must consider this behavior because the CPU code execution is faster than the ADC. As a result, in Manual Sample mode, particularly where the user's code is setting the SAMP bit (AD1CON1<1>), the DONE bit should also be cleared by the user application just before setting the SAMP bit.

5. Enabling op amps, comparator inputs and external voltage references can limit the availability of analog inputs (ANx pins). For example, when Op Amp 2 is enabled, the pins for ANO, AN1 and AN2 are used by the op amp's inputs and output. This negates the usefulness of Alternate Input mode since the MUXA selections use AN0-AN2. Carefully study the ADC block diagram to determine the configuration that will best suit your application. Configuration examples are available in the "Analog-to-Digital Converter (ADC)" (DS70621) section in the "dsPIC33/ PIC24 Family Reference Manual".

23.3 ADC Resources

Many useful resources are provided on the main product page of the Microchip web site for the devices listed in this data sheet. This product page, which can be accessed using this link, contains the latest updates and additional information.

Note:	In the event you are not able to access the
	product page using the link above, enter
	this URL in your browser:
	http://www.microchip.com/wwwproducts/
	Devices.aspx?dDocName=en555464

23.3.1 KEY RESOURCES

- "Analog-to-Digital Converter (ADC)" (DS70621) in the "dsPIC33/PIC24 Family Reference Manual"
- · Code Samples
- Application Notes
- Software Libraries
- Webinars
- All Related "dsPIC33/PIC24 Family Reference Manual" Sections
- Development Tools

24.3 PTG Control Registers

REGISTER 24-1: PTGCST: PTG CONTROL/STATUS REGISTER

R/W-0	U-0	R/W-0	R/W-0	U-0	R/W-0	R/W-0	R/W-0
PTGEN	—	PTGSIDL	PTGTOGL	—	PTGSWT ⁽²⁾	PTGSSEN ⁽³⁾	PTGIVIS
bit 15							bit 8
R/W-0	HS-0	U-0	U-0	U-0	U-0	R/V	V-0
PTGSTRT	PTGWDTO	_	_	_	_	PTGITM1 ⁽¹⁾	PTGITM0 ⁽¹⁾

h	it	7
υ	π.	1

Legend:	HS = Hardware Settable bit		
R = Readable bit	W = Writable bit	U = Unimplemented bit, read	l as '0'
-n = Value at POR	'1' = Bit is set	'0' = Bit is cleared	x = Bit is unknown

bit 15		PTGEN: Module Enable bit
		1 = PTG module is enabled
		0 = PTG module is disabled
bit 14		Unimplemented: Read as '0'
bit 13		PTGSIDL: PTG Stop in Idle Mode bit
		 1 = Discontinues module operation when device enters Idle mode 0 = Continues module operation in Idle mode
bit 12		PTGTOGL: PTG TRIG Output Toggle Mode bit
		 1 = Toggle state of the PTGOx for each execution of the PTGTRIG command 0 = Each execution of the PTGTRIG command will generate a single PTGOx pulse determined by the value in the PTGPWDx bits
bit 11		Unimplemented: Read as '0'
bit 10		PTGSWT: PTG Software Trigger bit ⁽²⁾
		1 = Triggers the PTG module
		0 = No action (clearing this bit will have no effect)
bit 9		PTGSSEN: PTG Enable Single-Step bit ⁽³⁾
		1 = Enables Single-Step mode
		0 = Disables Single-Step mode
bit 8		PTGIVIS: PTG Counter/Timer Visibility Control bit
		1 = Reads of the PTGSDLIM, PTGCxLIM or PTGTxLIM registers return the current values of their corresponding counter/timer registers (PTGSD, PTGCx, PTGTx)
		 Reads of the PTGSDLIM, PTGCxLIM or PTGTxLIM registers return the value previously written to those limit registers
bit 7		PTGSTRT: PTG Start Sequencer bit
		1 = Starts to sequentially execute commands (Continuous mode)0 = Stops executing commands
bit 6		PTGWDTO: PTG Watchdog Timer Time-out Status bit
		1 = PTG Watchdog Timer has timed out
		0 = PTG watchdog Timer has not timed out.
bit 5-2		Unimplemented: Read as '0'
Note	1: Th	nese bits apply to the PTGWHI and PTGWLO commands only.
	2: Th	is bit is only used with the PTGCTRL step command software trigger option.

3: Use of the PTG Single-Step mode is reserved for debugging tools only.

bit 0

25.1 Op Amp Application Considerations

There are two configurations to take into consideration when designing with the op amp modules that available in the dsPIC33EPXXXGP50X. are dsPIC33EPXXXMC20X/50X and PIC24EPXXXGP/ MC20X devices. Configuration A (see Figure 25-6) takes advantage of the internal connection to the ADC module to route the output of the op amp directly to the ADC for measurement. Configuration B (see Figure 25-7) requires that the designer externally route the output of the op amp (OAxOUT) to a separate analog input pin (ANy) on the device. Table 30-55 in Section 30.0 "Electrical Characteristics" describes the performance characteristics for the op amps, distinguishing between the two configuration types where applicable.

25.1.1 OP AMP CONFIGURATION A

Figure 25-6 shows a typical inverting amplifier circuit taking advantage of the internal connections from the op amp output to the input of the ADC. The advantage of this configuration is that the user does not need to consume another analog input (ANy) on the device, and allows the user to simultaneously sample all three op amps with the ADC module, if needed. However, the presence of the internal resistance, RINT1, adds an error in the feedback path. Since RINT1 is an internal resistance, in relation to the op amp output (VOAXOUT) and ADC internal connection (VADC), RINT1 must be included in the numerator term of the transfer function. See Table 30-53 in Section 30.0 "Electrical Characteristics" for the typical value of RINT1. Table 30-60 and Table 30-61 in Section 30.0 "Electrical Characteristics" describe the minimum sample time (TSAMP) requirements for the ADC module in this configuration. Figure 25-6 also defines the equations that should be used when calculating the expected voltages at points, VADC and VOAXOUT.

FIGURE 25-6: OP AMP CONFIGURATION A



Note 1: See Table 30-53 for the Typical value.

- 2: See Table 30-53 for the Minimum value for the feedback resistor.
- 3: See Table 30-60 and Table 30-61 for the minimum sample time (TSAMP).
- 4: CVREF10 or CVREF20 are two options that are available for supplying bias voltage to the op amps.

27.2 User ID Words

dsPIC33EPXXXGP50X, dsPIC33EPXXXMC20X/50X and PIC24EPXXXGP/MC20X devices contain four User ID Words, located at addresses, 0x800FF8 through 0x800FFE. The User ID Words can be used for storing product information such as serial numbers, system manufacturing dates, manufacturing lot numbers and other application-specific information.

The User ID Words register map is shown in Table 27-3.

TABLE 27-3:USER ID WORDS REGISTER
MAP

File Name	Address	Bits 23-16	Bits 15-0
FUID0	0x800FF8	—	UID0
FUID1	0x800FFA	—	UID1
FUID2	0x800FFC	—	UID2
FUID3	0x800FFE	—	UID3

Legend: — = unimplemented, read as '1'.

27.3 On-Chip Voltage Regulator

All of the dsPIC33EPXXXGP50X, dsPIC33EPXXXMC20X/50X and PIC24EPXXXGP/ MC20X devices power their core digital logic at a nominal 1.8V. This can create a conflict for designs that are required to operate at a higher typical voltage, such as 3.3V. To simplify system design, all devices in the dsPIC33EPXXXGP50X, dsPIC33EPXXXMC20X/50X and PIC24EPXXXGP/MC20X family incorporate an onchip regulator that allows the device to run its core logic from VDD.

The regulator provides power to the core from the other VDD pins. A low-ESR (less than 1 Ohm) capacitor (such as tantalum or ceramic) must be connected to the VCAP pin (Figure 27-1). This helps to maintain the stability of the regulator. The recommended value for the filter capacitor is provided in Table 30-5 located in **Section 30.0 "Electrical Characteristics"**.

Note: It is important for the low-ESR capacitor to be placed as close as possible to the VCAP pin.

FIGURE 27-1: CONNECTIONS FOR THE ON-CHIP VOLTAGE

REGULATOR^(1,2,3)



27.4 Brown-out Reset (BOR)

The Brown-out Reset (BOR) module is based on an internal voltage reference circuit that monitors the regulated supply voltage, VCAP. The main purpose of the BOR module is to generate a device Reset when a brown-out condition occurs. Brown-out conditions are generally caused by glitches on the AC mains (for example, missing portions of the AC cycle waveform due to bad power transmission lines or voltage sags due to excessive current draw when a large inductive load is turned on).

A BOR generates a Reset pulse, which resets the device. The BOR selects the clock source, based on the device Configuration bit values (FNOSC<2:0> and POSCMD<1:0>).

If an oscillator mode is selected, the BOR activates the Oscillator Start-up Timer (OST). The system clock is held until OST expires. If the PLL is used, the clock is held until the LOCK bit (OSCCON<5>) is '1'.

Concurrently, the PWRT Time-out (TPWRT) is applied before the internal Reset is released. If TPWRT = 0 and a crystal oscillator is being used, then a nominal delay of TFSCM is applied. The total delay in this case is TFSCM. Refer to Parameter SY35 in Table 30-22 of **Section 30.0 "Electrical Characteristics"** for specific TFSCM values.

The BOR status bit (RCON<1>) is set to indicate that a BOR has occurred. The BOR circuit continues to operate while in Sleep or Idle modes and resets the device should VDD fall below the BOR threshold voltage.

31.0 HIGH-TEMPERATURE ELECTRICAL CHARACTERISTICS

This section provides an overview of dsPIC33EPXXXGP50X, dsPIC33EPXXXMC20X/50X and PIC24EPXXXGP/ MC20X electrical characteristics for devices operating in an ambient temperature range of -40°C to +150°C.

The specifications between -40° C to $+150^{\circ}$ C are identical to those shown in **Section 30.0** "**Electrical Characteristics**" for operation between -40° C to $+125^{\circ}$ C, with the exception of the parameters listed in this section.

Parameters in this section begin with an H, which denotes High temperature. For example, Parameter DC10 in **Section 30.0 "Electrical Characteristics"** is the Industrial and Extended temperature equivalent of HDC10.

Absolute maximum ratings for the dsPIC33EPXXXGP50X, dsPIC33EPXXXMC20X/50X and PIC24EPXXXGP/MC20X high-temperature devices are listed below. Exposure to these maximum rating conditions for extended periods can affect device reliability. Functional operation of the device at these or any other conditions above the parameters indicated in the operation listings of this specification is not implied.

Absolute Maximum Ratings⁽¹⁾

Ambient temperature under bias ⁽²⁾	40°C to +150°C
Storage temperature	65°C to +160°C
Voltage on VDD with respect to Vss	-0.3V to +4.0V
Voltage on any pin that is not 5V tolerant with respect to Vss ⁽³⁾	-0.3V to (VDD + 0.3V)
Voltage on any 5V tolerant pin with respect to Vss when VDD < 3.0V ⁽³⁾	-0.3V to 3.6V
Voltage on any 5V tolerant pin with respect to Vss when $VDD \ge 3.0V^{(3)}$	-0.3V to 5.5V
Maximum current out of Vss pin	60 mA
Maximum current into VDD pin ⁽⁴⁾	60 mA
Maximum junction temperature	+155°C
Maximum current sourced/sunk by any 4x I/O pin	
Maximum current sourced/sunk by any 8x I/O pin	15 mA
Maximum current sunk by all ports combined	
Maximum current sourced by all ports combined ⁽⁴⁾	70 mA

- **Note 1:** Stresses above those listed under "Absolute Maximum Ratings" can cause permanent damage to the device. This is a stress rating only, and functional operation of the device at those or any other conditions above those indicated in the operation listings of this specification is not implied. Exposure to maximum rating conditions for extended periods can affect device reliability.
 - 2: AEC-Q100 reliability testing for devices intended to operate at +150°C is 1,000 hours. Any design in which the total operating time from +125°C to +150°C will be greater than 1,000 hours is not warranted without prior written approval from Microchip Technology Inc.
 - 3: Refer to the "Pin Diagrams" section for 5V tolerant pins.
 - 4: Maximum allowable current is a function of device maximum power dissipation (see Table 31-2).

31.2 **AC Characteristics and Timing Parameters**

The information contained in this section defines dsPIC33EPXXXGP50X, dsPIC33EPXXXMC20X/50X and PIC24EPXXXGP/MC20X AC characteristics and timing parameters for high-temperature devices. However, all AC timing specifications in this section are the same as those in Section 30.2 "AC Characteristics and Timing Parameters", with the exception of the parameters listed in this section.

Parameters in this section begin with an H, which denotes High temperature. For example, Parameter OS53 in Section 30.2 "AC Characteristics and Timing Parameters" is the Industrial and Extended temperature equivalent of HOS53.

TABLE 31-9: TEMPERATURE AND VOLTAGE SPECIFICATIONS – AC

AC CHARACTERISTICS	Standard Operating Conditions: 3.0V to 3.6V			
	(unless otherwise stated)			
	Operating temperature $-40^{\circ}C \le TA \le +150^{\circ}C$			
	Operating voltage VDD range as described in Table 31-1.			

FIGURE 31-1: LOAD CONDITIONS FOR DEVICE TIMING SPECIFICATIONS



TABLE 31-10: PLL CLOCK TIMING SPECIFICATIONS

AC CHARACTERISTICS			Standard Operating Conditions: 3.0V to 3.6V (unless otherwise stated) Operating temperature $-40^{\circ}C \le TA \le +150^{\circ}C$				
Param No.	Symbol	Characteristic	Min	Тур	Max	Units	Conditions
HOS53	DCLK	CLKO Stability (Jitter) ⁽¹⁾	-5	0.5	5	%	Measured over 100 ms period

These parameters are characterized by similarity, but are not tested in manufacturing. This specification is Note 1: based on clock cycle by clock cycle measurements. To calculate the effective jitter for individual time bases or communication clocks use this formula:

$$Peripheral Clock Jitter = \frac{DCLK}{\sqrt{\frac{FOSC}{Peripheral Bit Rate Clock}}}$$

For example: FOSC = 32 MHz, DCLK = 5%, SPIx bit rate clock (i.e., SCKx) is 2 MHz. Г

$$SPI SCK Jitter = \left\lfloor \frac{D_{CLK}}{\sqrt{\left(\frac{32 MHz}{2 MHz}\right)}} \right\rfloor = \left\lfloor \frac{5\%}{\sqrt{16}} \right\rfloor = \left\lfloor \frac{5\%}{4} \right\rfloor = 1.25\%$$

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TABLE 31-11: INTERNAL RC ACCURACY

AC CH	ARACTERISTICS	Standard Operating Conditions: 3.0V to 3.6V (unless otherwise stated)Operating temperature $-40^{\circ}C \le TA \le +150^{\circ}C$					
Param No.	Characteristic	Min	Тур	Max	Units	Conditions	
	LPRC @ 32.768 kHz ^(1,2)						
HF21	LPRC	-30	_	+30	%	$-40^{\circ}C \le TA \le +150^{\circ}C VDD = 3.0-3.6V$	

Note 1: Change of LPRC frequency as VDD changes.

2: LPRC accuracy impacts the Watchdog Timer Time-out Period (TwDT). See Section 27.5 "Watchdog Timer (WDT)" for more information.

32.0 DC AND AC DEVICE CHARACTERISTICS GRAPHS

Note: The graphs provided following this note are a statistical summary based on a limited number of samples and are provided for design guidance purposes only. The performance characteristics listed herein are not tested or guaranteed. In some graphs, the data presented may be outside the specified operating range (e.g., outside specified power supply range) and therefore, outside the warranted range.

FIGURE 32-1: VOH – 4x DRIVER PINS VOH (V) -0.050 -0.045 3.6V -0.040 3.3V -0.035 3V -0.030 IOH(A) -0.025 -0.020 Absolute Maximum -0.015 -0.010 -0.005 0.000 0.50 1.00 2.00 2.50 3.00 3.50 0.00 1.50 4.00

FIGURE 32-2: VOH – 8x DRIVER PINS





FIGURE 32-4: Vol – 8x DRIVER PINS





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28-Lead Plastic Small Outline (SO) - Wide, 7.50 mm Body [SOIC]

Note: For the most current package drawings, please see the Microchip Packaging Specification located at http://www.microchip.com/packaging





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